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Symbol	Parameter	Test Conditions	Min	Typ (Note 4)	Max	Units
t <sub>PLHD</sub>	Differential Propagation Delay LOW-to-HIGH		0.6	1.1	1.7	ns
t <sub>PHLD</sub>	Differential Propagation Delay HIGH-to-LOW		0.6	1.2	1.7	ns
t <sub>TLHD</sub>	Differential Output Rise Time (20% to 80%)	$R_L = 100 \ \Omega, \ C_L = 10 \ pF,$	0.4		1.2	ns
t <sub>THLD</sub>	Differential Output Fall Time (80% to 20%)	See Figure 2 (Note 8), and Figure 3	0.4		1.2	ns
t <sub>SK(P)</sub>	Pulse Skew  t <sub>PLH</sub> - t <sub>PHL</sub>				0.4	ns
t <sub>SK(LH)</sub> t <sub>SK(HL)</sub>	Channel-to-Channel Skew (Note 5)			0.05	0.3	ns
t <sub>SK(PP)</sub>	Part-to-Part Skew (Note 6)				1.0	ns
f <sub>MAX</sub>	Maximum Frequency (Note 7)	$R_L = 100\Omega$ , See Figure 6 (Note 8)	200	250		MHz
t <sub>ZHD</sub>	Differential Output Enable Time from Z to HIGH			1.7	5.0	ns
t <sub>ZLD</sub>	Differential Output Enable Time from Z to LOW	$R_L = 100\Omega$ , $C_L = 10 \text{ pF}$ ,		1.7	5.0	ns
t <sub>HZD</sub>	Differential Output Disable Time from HIGH to Z	See Figure 4 (Note 8), and Figure 5		2.7	5.0	ns
t <sub>LZD</sub>	Differential Output Disable Time from LOW to Z			2.7	5.0	ns
C <sub>IN</sub>	Input Capacitance			4.2		pF
COUT	Output Capacitance			5.2		pF

Note 4: All typical values are at  $T_A$  = 25  $^\circ C$  and with  $V_{CC}$  = 3.3V.

Note 5:  $t_{SK(LH)}$ ,  $t_{SK(HL)}$  is the skew between specified outputs of a single device when the outputs have identical loads and are switching in the same direction.

Note 6:  $t_{SK(PP)}$  is the magnitude of the difference in propagation delay times between any specified terminals of two devices switching in the same direction (either LOW-to-HIGH or HIGH-to-LOW) when both devices operate with the same supply voltage, same temperature, and have identical test circuits. Note 7:  $f_{MAX}$  criteria: Input  $t_R = t_F < 1ns$ , 0V to 3V, 50% Duty Cycle; Output  $V_{OD} > 250$  mv, 45% to 55% Duty Cycle; all switching in phase channels. Note 8: Test Circuits in Figures 2, 4, 6 are simplified representations of test fixture and DUT loading.

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## FIN1047

FIGURE 1. Differential Driver DC Test Circuit	Note A: All input pulses have frequency = 10 MHz, $t_{\rm R}$ or $t_{\rm F}$ = 1 ns Note B:



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